

**INFORMATION DISCLOSURE STATEMENT**

Applicant : Wen-Jian Lin
App. No : 10/807,129
Filed : March 24, 2004
For : AN INTERFERENCE DISPLAY CELL
Examiner : Evelyn A. Lester
Art Unit : 2873

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing 2 references to be considered by the Examiner. Also enclosed are 2 foreign patent references and/or non-patent literature as listed on the Information Disclosure Statement.

This Information Disclosure Statement is being filed after the mailing date of a final action or after the mailing date of a Notice of Allowance. This Statement is accompanied by the fee set forth in 37 C.F.R. § 1.17(p). The Commissioner is hereby authorized to charge any additional fees which may be required or to credit any overpayment to Account No. 11-1410.

Pursuant to 37 C.F.R. § 1.97(g) and (h), Applicants make no representation that the information is considered to be material to patentability. Additionally, inclusion on this list is not an admission that any of the cited documents are prior art in this application. Further, Applicants make no representation regarding the completeness of this list, nor represent that better art does not exist.

The IEEE article cited herein was cited in the Information Disclosure Statement filed on May 25, 2006. It is being cited again here in order to provide the Examiner with a more legible copy than previously provided. The Examiner is respectfully requested to consider this reference and confirm that the reference has been considered by initialing the PTO/SB/08 Equivalent.

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Appl. No. : 10/807,129
Filed : March 24, 2004

Docket No. QCO.087A
Customer No. 20,995

CERTIFICATION UNDER 37 C.F.R. § 1.97(e)(1)

I hereby certify that the foreign patent reference contained in this Statement was first cited in a communication from a foreign Patent Office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement.

The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment, to Account No. 11-1410.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: 12/18/06

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Application No.	10/807,129
Filing Date	March 24, 2004
First Named Inventor	Wen-Jian Lin
Art Unit	2873
Examiner	Evelyn A. Lester
Attorney Docket No.	QCO.087A

DEC 22 2006 (Multiple sheets used when necessary)

SHEET 1 OF 1

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
	1	2001-195189	09/07/2003	Fuji Photo Film Co. Ltd.		

NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹
	2	"IEEE Symposium on FPGAs for Custom Computing Machines"; April 15-17, 1998; Napa Valley, California; IEEE Computer Society Technical Committee on Computer Architecture; Edited by Kenneth L. Pocek and Jeffrey M. Arnold	
	3		
	4		
	5		
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Examiner Signature	Date Considered
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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T¹ - Place a check mark in this area when an English language Translation is attached.